

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/637,845	<b>Applicant(s)/Patent under Reexamination</b> STROPIANA, FERNANDO
	<b>Examiner</b> Mark Eashoo, Ph.D.	<b>Art Unit</b> 1732

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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